

## CGD65B130S2 DATASHEET

650 V / 130 mΩ GaN HEMT with ICeGaN<sup>™</sup> Gate and Current Sense

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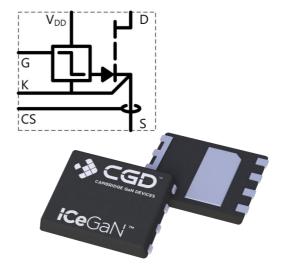
# 650 V / 130 mΩ GaN HEMT with ICeGaN<sup>™</sup> Gate and Current Sense

#### **Key features**

- 650 V 12 A e-mode GaN power switch
- ICeGaN<sup>™</sup> gate technology for high gate threshold and broad gate voltage window compatible with gate-drivers for Si MOSFETs
- Gate drive voltage 9 V to 20 V
- Current sense function
- R<sub>DS(on)</sub> = 130 mΩ
- Suitable for very high switching frequency
- Kelvin Contact
- Small 5x6 mm<sup>2</sup> PCB footprint
- Bottom side cooled DFN package

#### Description

The CGD65B130S2 is an enhancement mode GaN-on-silicon power transistor, exploiting the unique material properties of GaN to deliver high current, high breakdown voltage and high switching frequency for a wide range of electronics applications. The CGD65B130S2 features CGD's ICeGaN<sup>™</sup> gate technology enabling compatibility with virtually all gate drivers and controller chips available. The integrated current sense function eliminates a separate current sense resistor and the associated efficiency losses. Because no external sense resistor is needed, the device can be directly soldered to the large copper area of the ground plane, improving the thermal performance and simplifying the thermal design. It comes in a DFN 5x6 SMD package to support high frequency operation while ensuring the highest thermal performance.



#### **Application & Topologies**

PSUs, Industrial SMPS and inverters

- Server power and data centres
- Telecom rectifiers
- Gaming PSUs
- PC power
- LED drivers
- High power Class-D Audio
- General purpose SMPS
- PV inverters
- SMPS and converters in single-switch and halfbridge topologies with hard- or soft-switching
- AC/DC inverters
- Totem pole and single-switch PFC
- Forward, flyback and LLC converters at high frequency



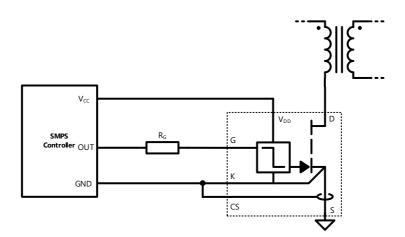
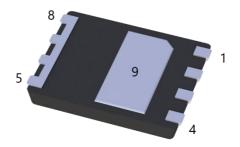


Figure 1. Exemplary Application Circuit



PIN	NAME	DESCRIPTION			
1	Kelvin Source	Kelvin source connection (internally tied to power HEMT source), reference			
		potential for gate voltage.			
2	Gate	Gate signal input.			
		Recommended gate-drive voltage: $V_{drive}$ ( $V_{GS}$ in on-state) = 9 V to $V_{DD}$ .			
3	Current Sense	Current sense output, relative to source, non-isolated.			
4	V <sub>DD</sub>	ICeGaN <sup>™</sup> gate supply voltage (recommended at 12 V), relative to source.			
5-8	Drain	Power HEMT drain			
9	Source	Power HEMT source, thermal pad			
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Figure 2. Pin Configuration and Functions



#### **Absolute Maximum Ratings**

 $T_{case}$  = 25 °C if not listed.

PARAMETER		VALUE	UNIT
Operating Junction Temperature	Τι	-55 to +150	°C
Storage Temperature Range	Ts	-55 to +150	°C
Drain-to-Source Voltage	V <sub>DS</sub>	650	V
Drain-to-Source Voltage - transient <sup>1</sup>	V <sub>DS(transient)</sub>	750	V
Gate-to-Source Voltage	V <sub>GS</sub>	-1 to +20	V
		and $V_{GS} \leq V_{DD}$	
Gate-to-Source Voltage - transient <sup>2</sup>	V <sub>GS(transient)</sub>	-1.5 to +21.5 and	V
		$V_{GS} \le V_{DD} + 1.5$	
Current Sense Voltage	V <sub>cs</sub>	-1.5 to 1.5	V
ICeGaN™ Gate Supply Voltage	V <sub>DD</sub>	0 to +20	V
Continuous Drain Current (T <sub>case</sub> = 25 °C)	ID	12	A

The recommended range of operation for  $V_{drive}$  ( $V_{GS}$  in on-state) and  $V_{DD}$  is 9 V to 20 V, enabling simple integration with a large variety of control chips and gate drivers.

Recommended maximum operating case temperature: T<sub>case</sub> = 125 °C.

<sup>&</sup>lt;sup>1</sup> Non-repetitive pulsed conditions, < 1 ms.

<sup>&</sup>lt;sup>2</sup> Non-repetitive pulsed conditions.



#### **Electrical Characteristics**

Values at  $T_J = 25 \text{ °C}$ ,  $V_{DD} = 12 \text{ V}$  if not listed. To turn the device on the recommended gate voltage range is  $V_{GS} = 9 \text{ V}$  to  $V_{DD}$ . To turn the device off set  $V_{GS} = 0 \text{ V}$ . An integrated Miller Clamp eliminates the need for negative gate voltages.

STATIC CHARACTERISTICS						
PARAMETER		CONDITIONS	MIN	ТҮР	MAX	UNIT
Drain-to-Source Blocking Voltage	BV <sub>DS</sub>	$V_{GS}$ = 0 V, $I_{DSS}$ = 8.5 $\mu$ A	650			V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 12 V, $I_{D}$ = 0.9 A		130	182	mΩ
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	T <sub>J</sub> = 150 °C		350		mΩ
		$V_{GS}$ = 12 V, $I_{D}$ = 0.9 A				
Source-to-Drain Voltage	V <sub>SD(on)</sub>	$V_{GS} = 0 V, I_{D} = 0.9 A$		2.0	3.7	V
Gate-to-Source Threshold	V <sub>GS(th)</sub>	V <sub>DS</sub> = 0.1 V, I <sub>D</sub> = 4.2 mA	2.2	2.9	4.2	V
Gate-to-Source Threshold	V <sub>GS(th)</sub>	T <sub>J</sub> = 150 °C		2.6		V
		V <sub>DS</sub> = 0.1 V, I <sub>D</sub> = 4.2 mA				
Gate-to-Source Current	I <sub>GS</sub>	$V_{GS} = 12 V, V_{DS} = 0 V$		2.8	3.7	mA
Gate-to-Source Current	I <sub>GS</sub>	T <sub>J</sub> = 150 °C		2.5		mA
		$V_{GS} = 12 V, V_{DS} = 0 V$				
V <sub>DD</sub> current	I <sub>VDD</sub>	$V_{GS} = 12 V, V_{DS} = 0 V$		1.8	2.8	mA
V <sub>DD</sub> current	I <sub>VDD</sub>	T <sub>J</sub> = 150 °C		1.1		mA
		$V_{GS} = 12 V, V_{DS} = 0 V$				
Drain-to-Source Leakage Current	I <sub>DSS</sub>	$V_{GS} = 0 V, V_{DS} = 650 V$		0.2	8.5	μA
Drain-to-Source Leakage Current	I <sub>DSS</sub>	T <sub>J</sub> = 150 °C		12		μA
-		$V_{GS} = 0 V, V_{DS} = 650 V$				

DYNAMIC CHARACTERISTICS								
PARAMETER		CONDITIONS	MIN	ΤΥΡ	MAX	UNIT		
Output Capacitance	Coss	$V_{DS} = 400 V, V_{GS} = 0 V$		25		рF		
		f = 100 kHz						
Output Charge	Q <sub>oss</sub>	$V_{DS} = 400 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		25		nC		
Total Gate Charge <sup>3</sup>	Q <sub>G</sub>	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 012 V		2.3		nC		
		I <sub>D</sub> = 4.2 A, I <sub>G</sub> = 20 mA						
Reverse Recovery Charge	Q <sub>RR</sub>	I <sub>S</sub> = 8 A, V <sub>DS</sub> = 400 V		0		nC		
Turn-on delay time	t <sub>d(on)</sub>	See Figure 17 and Figure 18		6		ns		
Turn-off delay time	t <sub>d(off)</sub>	See Figure 17 and Figure 18		20		ns		
Rise time	tr	See Figure 17 and Figure 18		6		ns		
Fall time	t <sub>f</sub>	See Figure 17 and Figure 18		6		ns		

<sup>&</sup>lt;sup>3</sup> Turn-on gate charge value is listed. Turn-off gate charge value is lower, because ICeGaN<sup>™</sup> gate discharges the gate internally.



#### **CURRENT SENSING**

Please refer to the application note CG-AN2206: Current Sensing with ICeGaN<sup>™</sup>. Please contact CGD for advice on the use of the current sense function.

#### **ESD RATING**

PARAMETER		CONDITIONS	MIN	ТҮР	MAX	UNIT
ESD withstand rating HBM		Human Body Model	2000			V
		(per JEDEC JS-001-2017)				

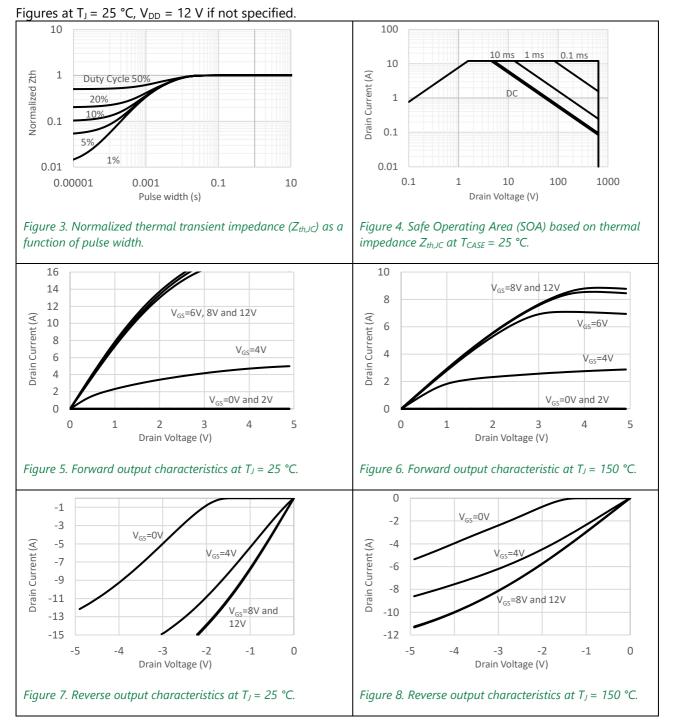
#### **Thermal Characteristics**

Typical values unless otherwise specified.

PARAMETER		CONDITIONS	VALUE	UNIT
Thermal resistance, junction to case	R <sub>th(JC)</sub>		2.3	°C/W
Maximum reflow soldering temperature	T <sub>reflow</sub>	MSL 1	260	°C

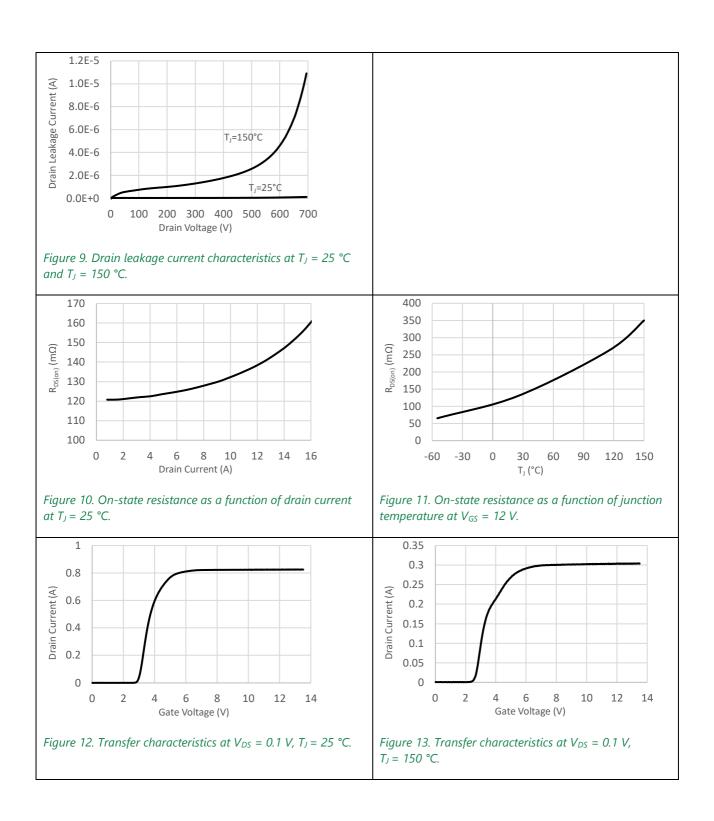


#### **Figures**

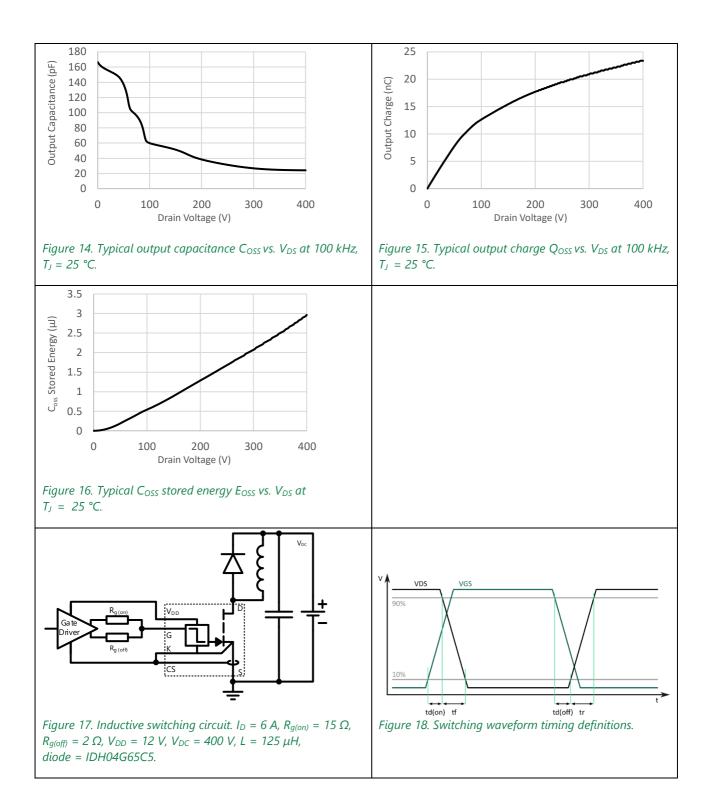


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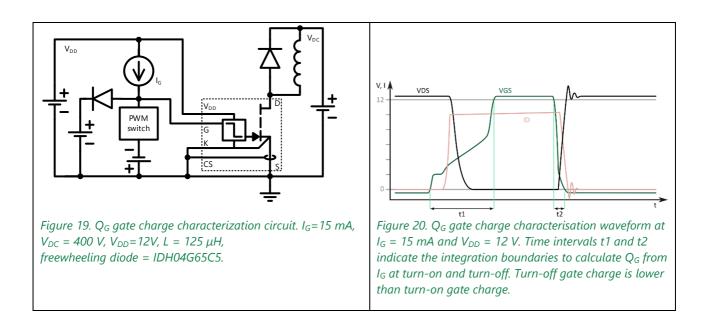






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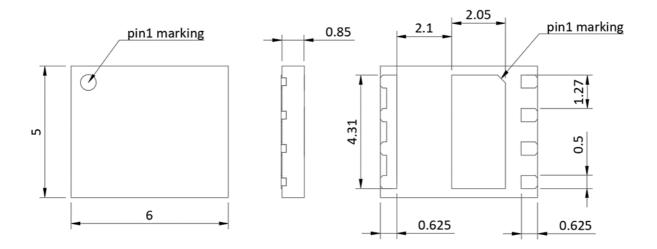


#### Packaging

DFN 5x6 mm.

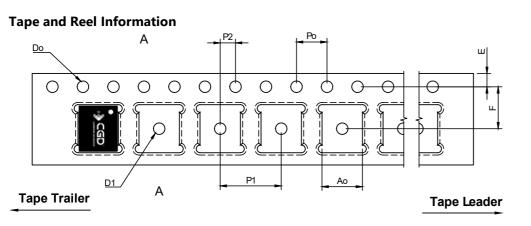
PIN NUMBER	NAME
1	Kelvin Source
2	Gate
3	Current Sense
4	V <sub>DD</sub>
5-8	Drain
9	Source

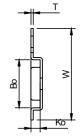




Like any unwanted electronic device, CGD components should be recycled or otherwise disposed of in accordance with local laws and regulations.





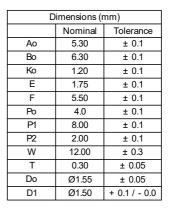


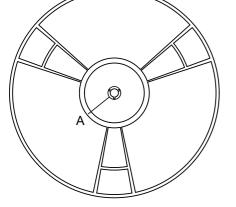
Detailed "A-A"

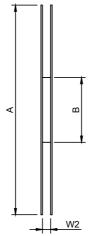
Tape Trailer - a minimum length of 160mm empty cavities sealed with cover tape. Tape Leader - a minimum length of 400mm empty cavities sealed with cover tape.



Isometric View







W1

Detail "A"

13" Reel Dimensions (mm)							
	Min Max						
W1		18.2					
W2	12.3	13.1					
А	328.0	332.0					
В	100.0	104.0					
С	20.2						
D	1.5	2.5					
E 12.8		13.5					

#### **Version History**

This version is 1.0									
VERSION	DESCRIPTION	DATE	BY						
1.0	Initial Release	December 2022	MA, AB, JZ						

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